Non-contact 3D Measuring System Hyper Quick Vision WLI Series



Catalog No. E14001(2)



Coordinate Measurement and Non-contact 3D Measurement in a Single System

Non-contact 2D/3D measurement with high precision and high resolution

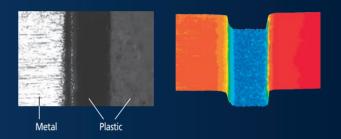
White light interferometer (WLI optical head) applied to vision measuring systems enables a wide range of powerful measurements, from 2D measurement of coordinates and dimensions, surface analysis in microscopic areas, depth measurement of small-diameter holes, and to high-precision 3D measurement of wiring dimensions on a printed circuit board.



Capable of handling a wide variety of measurement surfaces

WLI method can handle a wide variety of measurement surfaces including diffusing surfaces and mirrored surfaces.

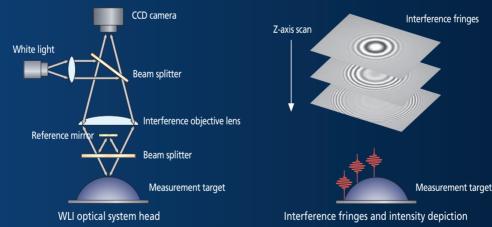
Using Mitutoyo's proprietary algorithm, WLI can also handle surfaces with large brightness differences, e.g., where plastic and metal coexist in mixed states.



Principle of WLI measurement

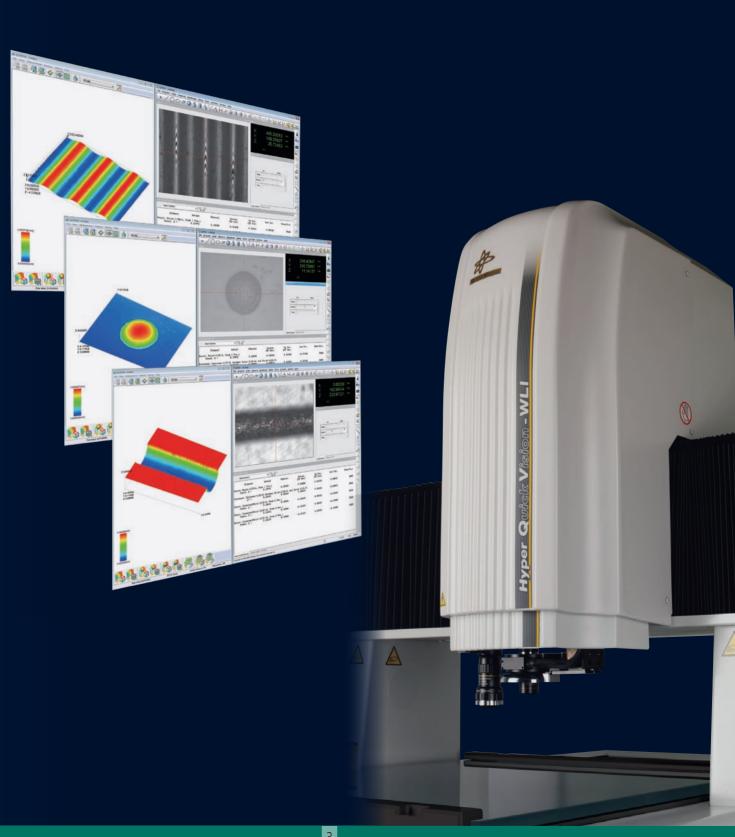
A white light is split into two beams, one for the reference mirror within the interference objective lens and the other for the measurement sample. When the interference objective lens is swept in the Z-direction, white interference fringes are generated only in the area of the measurement sample that is focused.

The three dimensional shape of the object being measured is calculated by detecting the peak position of the interference fringe intensity at each pixel position of the CCD camera.



Mitutoyo hite ight Interferometer

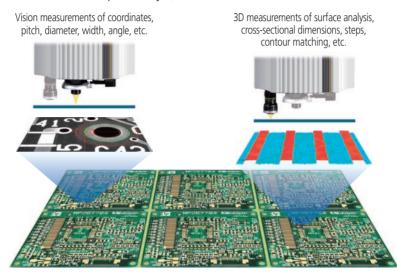
Advanced High Precision Dual Head Measuring System equipped with White Light Interferometer (WLI) Optical Head



Top Performance Presented by Continuously Evolving Vision Measuring Function and Advanced WLI Optical Head

High-efficiency measurement achieved by a single machine performing two roles

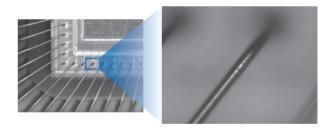
Coordinate dimension measurement has inherited all of the proven vision measuring functions of Quick Vision. Switches to 3D measurements without setup changes following vision measurement. Seamlessly continuous measurement is made possible by Quick Vision's automatic control.



Easy targeting of measurement position

Offset amount of vision optical head and WLI optical head is calibrated with high accuracy.

Switching to high-magnification WLI optical head after positioning with vision optical head of low magnification and a wide field of view does not lose sight of the targeted area, thus guaranteeing a highly efficient measurement.



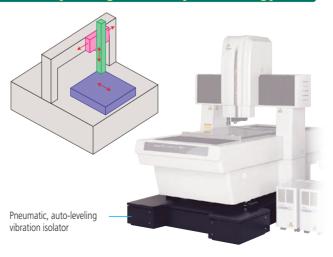
Advanced-design platform culminating from Mitutoyo's high accuracy technology

Main frame structure boasting a large stage and high accuracy is achieved by structure having a fixed bridge and a translation stage providing mutually independent X-axis and Y-axis movements, which are advantageous for achieving high accuracy. For added stability of measurement, a pneumatic auto-leveling vibration isolator is provided as a standard structure.

Unique design principle of Quick Vision series guarantees superb vibration isolation performance.

Achieves high precision measurement for a wide range of applications, from long dimensions of large workpieces to minute dimensions.







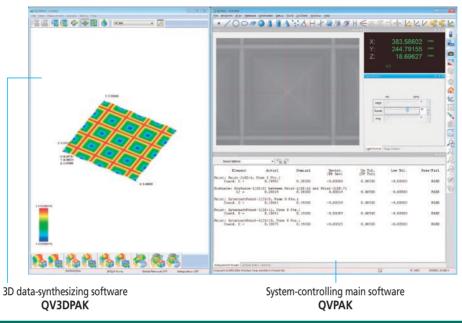
Hyper Quick Vision WLI606





Hyper Quick Vision WLI404

Software Powerfully supporting high functionality and measurement efficiency

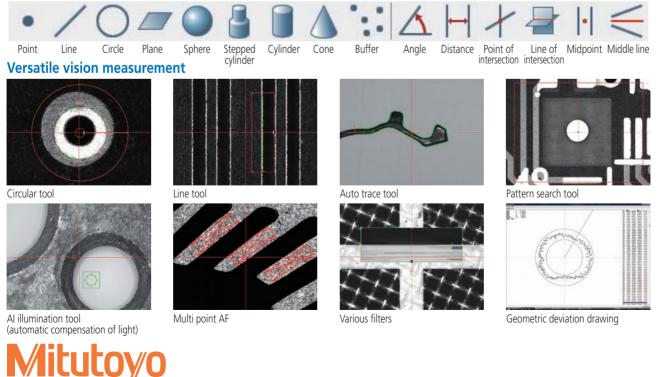


QVPAK2000

A function for acquiring interference fringes is added to QVPAK Software having high functionality and universal application capabilities for vision measuring systems.

The measurement procedure program prepared by QVPAK automatically controls the coordinates and dimensions in vision measurement, 3D data synthesis in WLI measurement, data output, and shape/evaluation analysis software (optional) thus providing a highly efficient measurement system.

Examples of computational capabilities



QV3DPAK

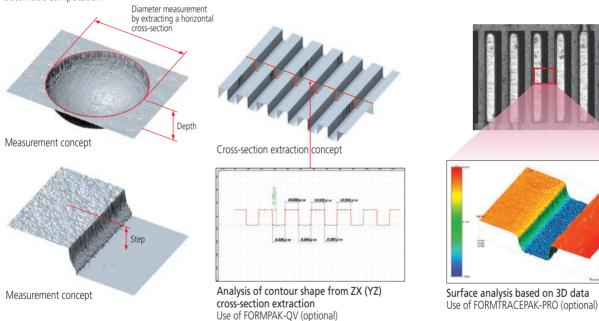
Synthesizes three dimensional shape data from interference fringes to display shapes or outputs point cloud data to external sources.

Point cloud data can be used for generating surfaces, as well as for outputting height, ID and OD dimensions.

Also, 3D data can be transferred to the shape/evaluation analysis software (optional) to implement shape measurement and surface analysis.

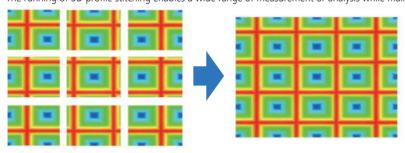
Applications

Enables you to switch from inaccurate visual inspections to accurate measurements based on automatic computation.



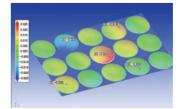
3D Profile Stitching

This function allows concatenation of multiple fields of 3D profile data unless only single field measurement can cover an object area to be measured. The running of 3D profile stitching enables a wide range of measurement or analysis while maintaining a high resolution.



MSURF-I

This software allows extraction of a geometric feature, assessment of a freecurved surface and profile, and tolerancing with master data by using point cloud data on the 3D profile surface acquired with a vision measuring system such as QV Hybrid and HQV-WLI/PFF.



* A separate PC is required for analysis by MSURF-I.

Optional Software

Shape evaluation and analysis software FORMPAK-AP

Performs design value cross-referencing and shape analysis based on shape data obtained using QV's Auto Trace Tool and WLI optical head.

Contour cross-referencing function

• Preparation of statistical data

CAD data conversion, master work conversion, function designation, text file conversion, aspheric design value preparation

•Design value referencing

Normal direction referencing, axial direction referencing, best fit referencing

Result display

Result listing, error line chart, error development diagram, error coordinate value display function, analysis result display

Microscopic shape analysis

 Analysis items: point measurement, line measurement, circle measurement, distance measurement, cross point measurement, angle measurement,

origin measurement, axial rotation • Computational items: maximum value, minimum value,

mean value, standard deviation, area

Report preparation function

Measurement report, error line chart, error development diagram

Other functions

- •Recording/execution of analysis procedure
- •External output function
 - CSV-format output, text output, and DXF/IGES format output
- Fairing process
- Quadratic curve fitting function
- Quasi-roughness analysis function

Shape evaluation and analysis software FORMTRACEPAK-PRO

Software for conducting analysis process based on point cloud data obtained via WLI optical head. If a two-dimensional analysis does not provide sufficient and reliable results, the software provides a three-dimensional evaluation and analysis method.

Major functions

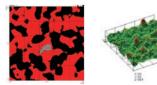
Three-dimensional display

Capable of wireframing, shading, contouring, setting up of color setting free for contour fill, and illumination setting, and allows the user to freely rotate, enlarge, shrink, or move the analysis target.

Trend compensation, filter process

Capable of trend compensation using planes, spheres, cylindrical surfaces, and polyhedrons. Filter process can be chosen from one-dimensional digital filter and two-dimensional digital filter for each profile.





Shading display

Wireframe display

Rich functions for digitization and graphical display of surface shapes

Capable of evaluation of wear and oil sump using relative load curves and area distribution curves.

Spectral analysis, analysis of cross-sectional areas and volumes, calculation of tilt angles of peaks and valleys, and histogram calculation of number of peaks and valleys.

Rich feature-extraction functions based on measurement data

Capable of slope intensification, simultaneous analysis of peaks and valleys of cross section, and extraction of arbitrary cross-sections.

Other optional software for Quick Vision is also available. For details, please refer to the catalog for the Quick Vision series.

3D Surface Texture Analysis Software MCubeMap

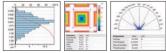
Clear and informative imaging of analyzed data using powerful graphics technology

Example of cross-section

analysis

The software is compatible with the latest ISO25178-2 3D Surface Texture Parameter Standard, allowing analysis of parameters such as height of Sa, Sq, etc., space, compound and volume.

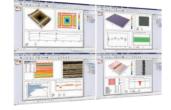
The user can easily create a graphical report where analysis results are freely laid out.



* The specifications of a measuring system are decided in consultation with the customer.

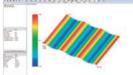
Abundant Data Manipulation and Analysis Functions

This function handles leveling, outlier processing, form elimination, bearing area curve, peak distribution, twist analysis*, hole/protrusion volume, texture orientation, and others.



Other optional software programs for Quick Vision are also available.For detailed information, refer to the Quick Vision series catalog.





Hardware Options

Objective lens

QV objective lens



Objective Lens	Code No.	PPT Magnifi- cation	Monitor Magnifi- cation	Field of View (mm)	Operating Distance*1 (mm)
	02AKT199	1×	14×	12.54×9.4	30.5
$QV-SL0.5 \times *^2$		2×	28×	6.27×4.7	
		6×	83×	2.09×1.56	
	02AKT250 02ALA150	1×	28×	6.27×4.7	40.6 52.5
QV-HR1× QV-SL1×		2×	55×	3.13×2.35	
QV-JETA		6×	165×	1.04×0.78	
	02AKT300 02ALA170	1×	69×	2.5×1.88	40.6 60
$QV-HR2.5 \times QV-SL2.5 \times$		2×	138×	1.25×0.94	
QV-3L2.3 ^		6×	415×	0.41×0.31	
	02ALA420	1×	138×	1.25×0.94	33.5
QV-5×		2×	276×	0.62×0.47	
		6×	829×	0.2×0.15	
$QV-HR10 \times *^2$ $QV-10 \times$	02AKT650 02ALG010	1×	276×	0.62×0.47	20 30.5
		2×	553×	0.31×0.23	
		6×	1672×	0.1×0.07	
	02ALG020	1×	961×	0.25×0.18	13
QV-25× * ² * ³		2×	1382×	0.12×0.09	
		6×	4147×	0.04×0.03	

Monitor magnification shown here is that of Size 24 Liquid Crystal Display (resolution WUXGA). *1 PRL lighting unit can be shorter than the operating distance due to the operating

position of the Programmable Ring Light (PRL) depending on the location of PRL. *2 Illumination can be insufficient in some cases depending on the workpiece.

*3 There is a limitation to the operating position of PRL.

WLI interference objective lens



Objective Lens	Code No.	Inter- ference Method	Monitor Magnifi- cation	Field of View*1 (mm)	Operating Distance (mm)
QV WLI A-5 $ imes$	02ALY400	Mirror	270×	0.64×0.48	13.2
QV WLI A-10 $ imes$	02ALT630	Mirror	540×	0.32×0.24	12.6
QV WLI A-25 $ imes$	02ALT670	Mirror	1350×	0.13×0.10	4.7
10 IV	1 1 1		111 110		

Monitor magnification shown here is that of Size 24 Liquid Crystal Display (resolution WUXGA). *1 Tube lens 2X is provided as a standard equipment. Also, the field of view may be smaller than those shown here due to pixel calibration.

Calibration

Tilt compensation jig for WLI optical head

Enables to compensate the mounting posture of WLI optical head. It helps to achieve measurement of the highest accuracy by compensating the tilting error of WLI optical head.



Interference fringe adjustment jig

Enables to adjust the focusing position of WLI interference objective lens with the position where interference fringes occur. It is used in combination with the calibration chart.



Interference adjustment jig

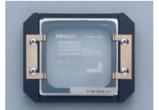
Calibration chart

Calibration chart (for vision optical head & WLI optical head)

Used for pixel size compensation of CCDs and for compensating autofocusing accuracy and optical axis offset at various magnifications of variable magnification PPT/zooming.

Note: There are some limitations to the function of each lens. Please contact one of our sales offices for details

QV compensation chart (for vision optical head)



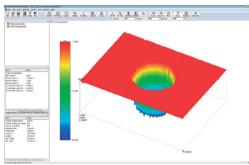
Glass chart designed for "in-screen compensation" to compensate for the distortion occurring in the screen caused by the optical system and for "auto-focusing compensation" to minimize auto-focusing fluctuations caused by the object' pattern and texture.

Note: There are some limitations to the function of each lens. Please contact one of our sales offices for details

Measurement Examples

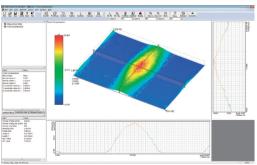
Surface analysis

Laser-machined hole



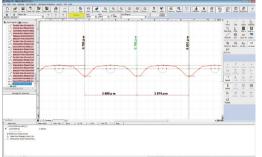
ID and depth measurements

Pole

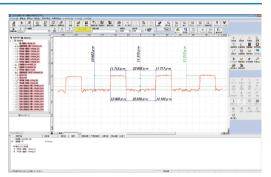


Cross-sectional shape measurement

Microscopic precision machined part—

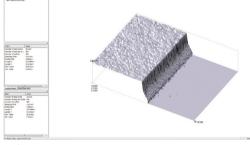


Cross-sectional shape measurement



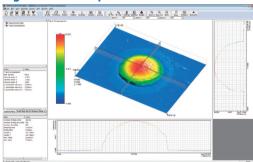
Cross-sectional shape measurement

Metal thin film ·

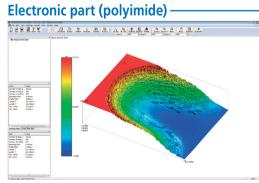


Surface analysis, and step measurement

Light induction plate -



Coordinate-position, OD, and height measurements



Surface analysis, step, and cross sectional measurements

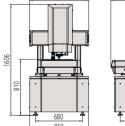
Specifications

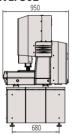
Model			Hyper Quick Vision WLI 302	Hyper Quick Vision WLI 404	Hyper Quick Vision WLI 606		
Optical system		QVW-H302P1L-D	QVW-H404P1L-D	QVW-H606P1L-D			
Order No.			363-713	363-714	363-715		
WLI optical head unit							
Measuring range*1 (Xx)	YxZ)		215 X 200 X 190mm	315 X 400 X 240mm	515 X 650 X 220mm		
CCD camera			Black & White				
Illumination Unit Co-axial Light			Halogen				
Z-axis maximum measu	ring range		QVWLI A-5x: 3.6mm, QVWLI A-10x: 3.6mm, QVWLI A-25x: 2.2mm				
Z-axis Repeatability			$2\sigma \leq 0.08\mu\mathrm{m}$				
Vision optical head uni	t						
Measuring range (XxYx)	Z)		300 X 200 X 190mm	400 X 400 X 240mm	600 X 650 X 220mm		
Observation unit				PPT 1X-2X-6X			
CCD camera				Black & White			
	Co-axial Light			White LED			
Illumination Unit	Transmitted Light		White LED				
	PRL		White LED				
		E1x, E1y	(0.8+2L/1000) μ m				
Measuring accuracy*2		E1z	(1.5+2L/1000) μm				
		E2XY	(1.4+3L/1000) μm				
Main unit							
Guide method		Linear hard bearing					
Resolution of scale / Sca	ale type		0.01 μ m / Linear Encoder				
Stage glass size			399 X 271mm	493 X 551mm	697 X 785mm		
Maximum stage loading	·		15kg	25kg	35kg		
Main unit external dimensions		859 X 950 X 1606mm	1027 X 1407 X 1781mm	1309 X 1985 X 1792mm			
Main unit mass (includi			490kg	1160kg	2275kg		
Installation environme	nt condition						
	Temperature condition	Range	20±1°C				
Accuracy-guaranteed environment		Fluctuation	0.5°C / 1H				
		Slope	1°C /m (height and horizontal direction)				
	Vibration		Max. amplitude $\leq 2 \mu$ m at frequency of 10Hz or lower				
	Acoustic condition		70db or lower				
Operating air pressure			0.4 MPa				
Power source voltage			AC100 - 240V				
Temperature compensa	tion function			Automatic			

*1 Movable range of WLI optical head. Three dimensional shape measurement using WLI is allowed within one field of vision.
*2 Determined by Mitutoyo's inspection method. L is measured length (mm).
The optical condition for accuracy assurance is to be (QV-HR2.5X or QV-SL2.5X) + Middle magnification of the tube lens.
*3 An excessively biased or concentrated load is excluded.
* Append "S" to the end of order number to order a QV machine compatible with ISO10360-7:2011 Accuracy Assurance.
* Hyper QV WLI is not compatible with the Easy Editor function of QVPAK.

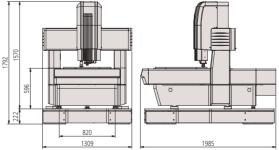
External view dimension chart

Hyper Quick Vision WLI 302

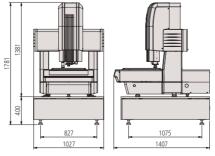


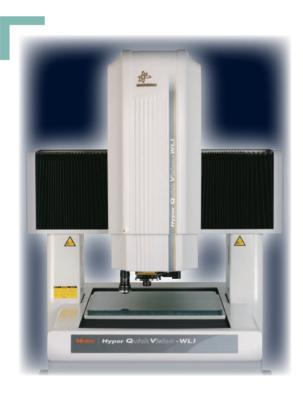


Hyper Quick Vision WLI 606



Hyper Quick Vision WLI 404





Note: All information regarding our products, and in particular the illustrations, drawings, dimensional and performance data contained in this pamphlet, as well as other technical data are to be regarded as approximate average values. We therefore reserve the right to make changes to the corresponding designs, dimensions and weights. The stated standards, similar technical regulations, descriptions and illustrations of the products were valid at the time of printing. Only quotations submitted by ourselves may be regarded as definitive.

May be regulated as inclusion with the second secon

Export permission by the Japanese government may be required for exporting our products according to the Foreign Exchange and Foreign Trade Law. Please consult our sales office near you before you export our products or you offer technical information to a nonresident.

Coordinate Measuring Machines	
Vision Measuring Systems	
Form Measurement	
Optical Measuring	
o parear intersering	
C C 1	
Sensor Systems	
Test Equipment and	
Seismometers	
Digital Scale and DBO Systems	
Digital Scale and DRO Systems	
Small Tool Instruments and	
Data Management	

Mitutoyo Corporation

20-1, Sakado 1-Chome, Takatsu-ku, Kawasaki-shi, Kanagawa 213-8533, Japan T +81 (0) 44 813-8230 F +81 (0) 44 813-8231 http://www.mitutoyo.co.jp

